# MOSFET – Power, Single, N-Channel, SO-8FL 30 V, 66 A

## **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Thermally Enhanced SO8 Package
- These are Pb-Free Devices

## **Applications**

- Refer to Application Note AND8195/D
- CPU Power Delivery
- DC-DC Converters
- High Side Switching

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

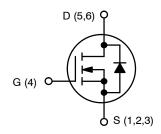
Para	Parameter			Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	30	V
Gate-to-Source Vol	tage		$V_{GS}$	±16	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	15	Α
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 85°C		10.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.16	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	24.3	Α
Current R <sub>θJA</sub> ≤ 10 sec		T <sub>A</sub> = 85°C		17.5	
Power Dissipation $R_{\theta JA,} t \leq 10 \text{ sec}$	Steady	T <sub>A</sub> = 25°C	P <sub>D</sub>	5.67	W
Continuous Drain Current R <sub>BJA</sub>	State	T <sub>A</sub> = 25°C	I <sub>D</sub>	9.5	Α
(Note 2)		T <sub>A</sub> = 85°C		6.9	
Power Dissipation $R_{\theta JA}$ (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.87	W
Continuous Drain	1	T <sub>C</sub> = 25°C	I <sub>D</sub>	66	Α
Current R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 85°C		47.8	
Power Dissipation $R_{\theta JC}$ (Note 1)		T <sub>C</sub> = 25°C	P <sub>D</sub>	41.7	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	132	Α
Current limited by package T <sub>A</sub> = 25°C		I <sub>Dmaxpkg</sub>	100	Α	
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	
Source Current (Boo	Source Current (Body Diode)		I <sub>S</sub>	41.7	Α
Drain to Source dV/dt		dV/dt	6	V/ns	



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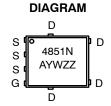
V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	5.9 mΩ @ 10 V	00.4
30 V	8.7 mΩ @ 4.5 V	66 A



**N-CHANNEL MOSFET** 



## SO-8 FLAT LEA CASE 488AA STYLE 1



**MARKING** 

A = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4851NT1G	SO-8FL (Pb-Free)	1500 / Tape & Reel
NTMFS4851NT3G	SO-8FL (Pb-Free)	5000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise stated)

Parameter	Symbol	Value	Unit
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = 50 V, $V_{GS}$ = 10 V, $I_L$ = 27 $A_{pk}$ , $L$ = 0.3 mH, $R_G$ = 25 $\Omega$ )	EAS	109	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	3.0	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	57.8	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	143.5	*C/VV
Junction-to-Ambient - t ≤ 10 sec	$R_{ heta JA}$	22.1	

- Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
   Surface-mounted on FR4 board using the minimum recommended pad size.

# **ELECTRICAL CHARACTERISTICS** (T.I = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			l l			1
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D =$	250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /				25		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 25 °C			1	
			T <sub>J</sub> = 125°C			10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub>	= ±16 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μΑ	1.45	1.8	2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				4.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V to	I <sub>D</sub> = 30 A		4.3	5.9	
	11.5 V	I <sub>D</sub> = 15 A		4.2		1	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		6.6	8.7	mΩ
			I <sub>D</sub> = 15 A		6.5		
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> = 30 A			62		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>				1850		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 12 V			333		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				170		1
Total Gate Charge	Q <sub>G(TOT)</sub>				13.5	20	
Threshold Gate Charge	Q <sub>G(TH)</sub>	V 45VV 4	5 \		1.7		]
Gate-to-Source Charge	$Q_{GS}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			5.1		nC
Gate-to-Drain Charge	$Q_{GD}$				4.5		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 11.5 V, V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A			32		nC
SWITCHING CHARACTERISTICS (Note 4)			_				
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			14.4		
Rise Time	t <sub>r</sub>				39.8		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				18.6		ns

Fall Time

3. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 4. Switching characteristics are independent of operating junction temperatures.

5.2

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (N	ote 4)				•		
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 15 A, $R_{G}$ = 3.0 $\Omega$			9.5		- ns
Rise Time	t <sub>r</sub>				22		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				25		
Fall Time	t <sub>f</sub>				4.6		
DRAIN-SOURCE DIODE CHARACT	ERISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 30 A	T <sub>J</sub> = 25°C		0.84	1.0	V
			T <sub>J</sub> = 125°C		0.73		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 30 \text{ A}$			13.2		ns
Charge Time	t <sub>a</sub>				8.5		
Discharge Time	t <sub>b</sub>				4.7		
Reverse Recovery Charge	$Q_{RR}$				3.5		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.93		nΗ
Drain Inductance	L <sub>D</sub>				0.005		
Gate Inductance	L <sub>G</sub>				1.84		
Gate Resistance	$R_{G}$				0.9		Ω

<sup>3.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

## **TYPICAL CHARACTERISTICS**

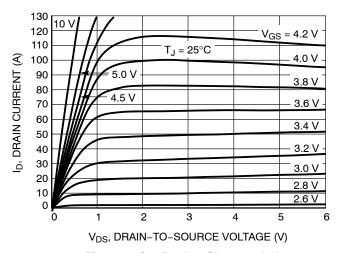


Figure 1. On-Region Characteristics

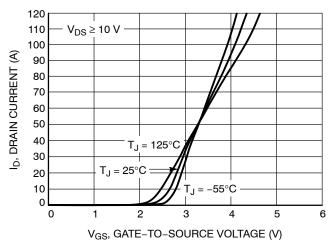
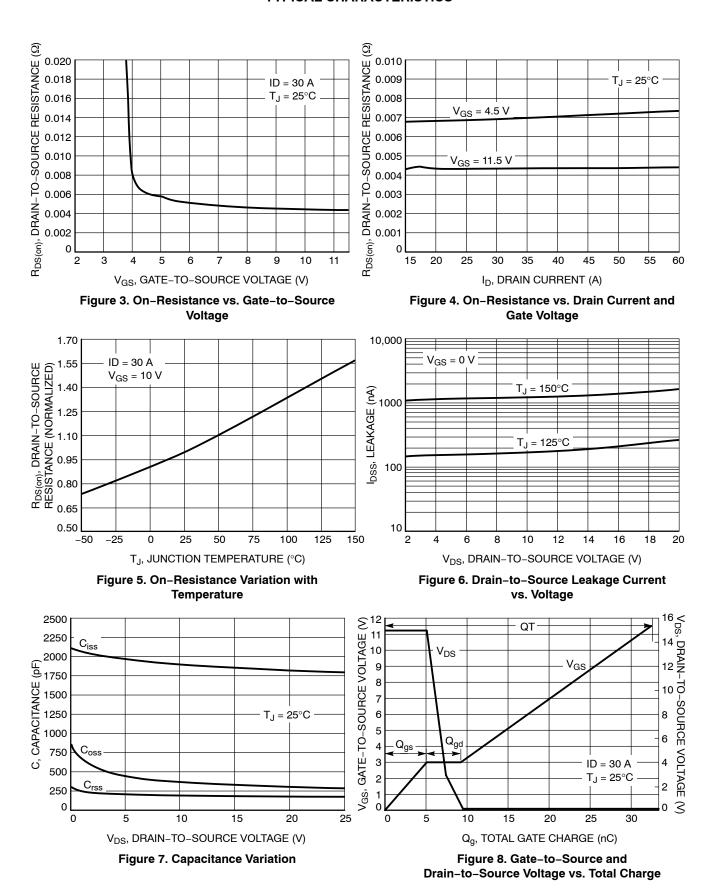


Figure 2. Transfer Characteristics

<sup>4.</sup> Switching characteristics are independent of operating junction temperatures.

## **TYPICAL CHARACTERISTICS**



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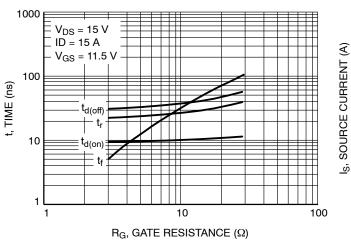


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

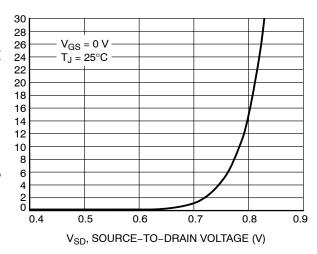


Figure 10. Diode Forward Voltage vs. Current

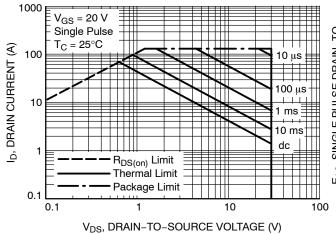


Figure 11. Maximum Rated Forward Biased Safe Operating Area

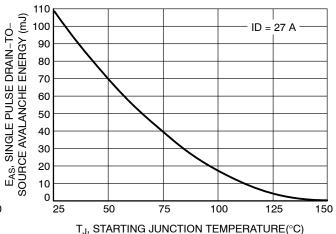


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

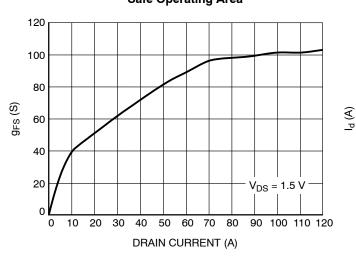


Figure 13. g<sub>FS</sub> vs. Drain Current

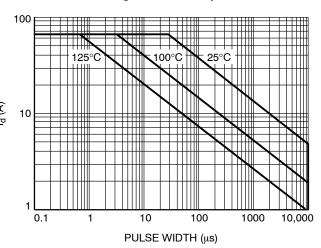


Figure 14. Avalanche Characteristics





0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

**DATE 25 JUN 2018** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETER. DIMENSION D1 AND E1 DO NOT INCLUDE
- MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
b	0.33	0.41	0.51		
С	0.23	0.28	0.33		
D	5.00	5.15	5.30		
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC	)		
G	0.51	0.575	0.71		
K	1.20	1.35	1.50		
L	0.51	0.575	0.71		
L1	0.125 REF				
M	3.00	3.40	3.80		
θ	0 °		12 °		

## **GENERIC MARKING DIAGRAM\***



XXXXXX = Specific Device Code

= Lot Traceability

= Assembly Location Α

Υ = Year W = Work Week

ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL** A

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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